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| Notice of References Cited | Application/Control No. 10/085,264 | Applicant(s)/Patent Under Reexamination NAKAMURA ET AL. | |
| | Examiner Kimberly E. Glenn | Art Unit 2817 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|---------------------|----------------|
| | A | US-5,205,652 | 04-1993 | Chapman, William I. | 384/119 |
| | B | US-5,634,200 | 05-1997 | Kitakubo et al. | 455/82 |
| | C | US-6,351,195 | 02-2002 | Atokawa et al. | 333/134 |
| | D | US-6,525,624 | 02-2003 | Hikita et al. | 333/133 |
| | E | US-6,809,611 | 10-2004 | Ishizaki et al. | 333/133 |
| | F | US-6,861,924 | 03-2005 | Machui, Jurgen | 333/133 |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
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| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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